WEST Search History

Hide Items Restore Clear Cancel

DATE: Tuesday, March 09, 2004

Hide?	<u>Set</u> Name	Query	<u>Hit</u> Count		
DB=PGPB, USPT, USOC, EPAB, JPAB, DWPI, TDBD; PLUR=YES; OP=ADJ					
	L29	(Calibrat\$3 or deskew\$3) same shar\$3 same (pad\$4 or pin or terminal or port or channel or leads) same accura\$4 same Semiconductor	11		
	L28	('US20020199141A')!.PN.	0		
\mathbf{m}	L27	('20020199141' '20020135357')!.PN.	4		
	L26	test\$3 and calibrat\$3 same (ic or (integrat\$3 near2 circuit\$3) or semi\$1conduct\$7 or semi conduct\$7 or memor\$7) same (de\$1skew\$3 or skew\$3 or lat\$7 or retard\$6) same (pad\$4 or pin or terminal or port or channel or leads) with (shar\$3 or common or joint)	19		
	L25	('20030234645')!.PN.	2		
	L24	L23 and 'dut' same test\$3 same (doubl\$4 or PARALLEL\$4 OR CONCUR\$7 OR PIPE\$1LIN\$4 OR SIMULTANE\$7 OR "SAME TIME" OR CONTEMPORan\$7 or CONTEMPO\$7 or contemporaneously) and shar\$3	1 .		
Г	L23	L22 and 'dut' same test\$3 same (doubl\$4 or PARALLEL\$4 OR CONCUR\$7 OR PIPE\$1LIN\$4 OR SIMULTANE\$7 OR "SAME TIME" OR CONTEMPORan\$7 or CONTEMPO\$7 or contemporaneously)	8		
	L22	L21 and 'dut'	18		
m	L21	test\$3 same calibrat\$3 same (ic or (integrat\$3 near2 circuit\$3) or semi\$1conduct\$7 or semi conduct\$7 or memor\$7) same (synchron\$6 or timing or de\$1skew\$3 or skew\$3 or lat\$7 or retard\$6) same (pad\$4 or pin or terminal or port or channel) same (program or adjust or vari or vary or configur)	106		
	L20	('6073259')!.PN.	2		
	L19	('6629052')!.PN.	2		
	L18	('6105157')!.PN.	2		
	L17	('4806852')!.PN.	2		
	L16	automat\$7 near2 test\$3 same calibrat\$3 and (ic or (integrat\$3 near2 circuit\$3) or semi\$1conduct\$7 or semi conduct\$7 or memor\$7) same (synchron\$6 or timing or de\$1skew\$3 or skew\$3 or lat\$7 or retard\$6) same (pad or pin or terminal or port or channel) same (program or adjust or vari or vary or configur) same (maxim or optim or reduc\$4 or increas\$3)	9		
	L15	L14 and automat\$7 with test\$3 same calibrat\$3 same (ic or (integrat\$3 near2 circuit\$3) or semi\$1conduct\$7 or semi conduct\$7 or memor\$7) same (synchron\$6 or timing or de\$1skew\$3 or skew\$3 or lat\$7 or retard\$6) same (pad\$4 or pin or terminal or port or channel) same (program or adjust or vari or vary or configur) same (maxim or optim) L13 and automat\$7 with test\$3 same calibrat\$3 same (ic or (integrat\$3 near2 circuit\$3) or semi\$1conduct\$7 or semi conduct\$7 or memor\$7) same	0		
		circuity of semination ductor of semination of memoral same			

	L14	(synchron\$6 or timing or de\$1skew\$3 or skew\$3 or lat\$7 or retard\$6) same (pad\$4 or pin or terminal or port or channel) same (program or adjust or vari or vary or configur)	16
	L13	L12 and automat\$7 with test\$3 same calibrat\$3 same (ic or (integrat\$3 near2 circuit\$3) or semi\$1conduct\$7 or semi conduct\$7 or memor\$7) same (synchron\$6 or timing or de\$1skew\$3 or skew\$3 or lat\$7 or retard\$6) same (pad\$4 or pin or terminal or port or channel)	48
	L12	L11 and automat\$7 with test\$3 same calibrat\$3 same (ic or (integrat\$3 near2 circuit\$3) or semi\$1conduct\$7 or semi conduct\$7 or memor\$7) same (synchron\$6 or timing or de\$1skew\$3 or skew\$3 or lat\$7 or retard\$6)	83
	L11	L10 and automat\$7 with test\$3 same calibrat\$3 same (ic or (integrat\$3 near2 circuit\$3) or semi\$1conduct\$7 or semi conduct\$7 or memor\$7)	423
	L10	automat\$7 with test\$3 same calibrat\$3	2958
П	L9	(shar\$3 or common or joint) near2 delay\$3 same automatic with test\$3 same (doubl\$4 or PARALLEL\$4 OR CONCUR\$7 OR PIPE\$1LIN\$4 OR SIMULTANE\$7 OR "SAME TIME" OR CONTEMPORan\$7 or CONTEMPO\$7 or contemporaneously) with (lead or pad\$4 or pin or terminal or port)	1
	L8	shar\$3 near2 delay\$3 same automatic with test\$3 same (doubl\$4 or PARALLEL\$4 OR CONCUR\$7 OR PIPE\$1LIN\$4 OR SIMULTANE\$7 OR "SAME TIME" OR CONTEMPORan\$7 or CONTEMPO\$7 or contemporaneously) with (lead or pad\$4 or pin or terminal or port)	0
m	L7	shar\$3 near2 delay\$3 same automatic with test\$3 same (doubl\$4 or PARALLEL\$4 OR CONCUR\$7 OR PIPE\$1LIN\$4 OR SIMULTANE\$7 OR "SAME TIME" OR CONTEMPORan\$7 or CONTEMPO\$7 or contemporaneously)	0
	L6	11 and shar\$3 near2 delay\$3 same automatic with test\$3 same (doubl\$4 or PARALLEL\$4 OR CONCUR\$7 OR PIPE\$1LIN\$4 OR SIMULTANE\$7 OR "SAME TIME" OR CONTEMPORan\$7 or CONTEMPO\$7 or contemporaneously)	0
	L5	11 and shar\$3 near2 delay\$3 same automatic test\$3 same (doubl\$4 or PARALLEL\$4 OR CONCUR\$7 OR PIPE\$1LIN\$4 OR SIMULTANE\$7 OR "SAME TIME" OR CONTEMPORan\$7 or CONTEMPO\$7 or contemporaneously)	0
	L4	11 and shar\$3 near2 delay\$3 same automatic test\$3 and parallel\$3	0
	L3	11 and shar\$3 near2 delay\$3 same automatic test\$3 same parallel\$3	0
	L2	11 and shar\$3 near2 delay\$3 bsame automatic test\$3	0
	Ll	shar\$3 near2 delay\$3	1022

END OF SEARCH HISTORY

WEST Search History

Hide Items Restore Clear Cancel

DATE: Tuesday, March 09, 2004

Hide?	<u>Set</u> Name	Query	<u>Hit</u> Count			
DB=PGPB,USPT,USOÇ,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=ADJ						
	L19	('6629052')!.PN (657 3259)	2			
	L18	('6105157')!.PN.	2			
	L17	('4806852')!.PN.	2			
	L16	automat\$7 near2 test\$3 same calibrat\$3 and (ic or (integrat\$3 near2 circuit\$3) or semi\$1conduct\$7 or semi conduct\$7 or memor\$7) same (synchron\$6 or timing or de\$1skew\$3 or skew\$3 or lat\$7 or retard\$6) same (pad or pin or terminal or port or channel) same (program or adjust or vari or vary or configur) same (maxim or optim or reduc\$4 or increas\$3)	9			
	L15	L14 and automat\$7 with test\$3 same calibrat\$3 same (ic or (integrat\$3 near2 circuit\$3) or semi\$1conduct\$7 or semi conduct\$7 or memor\$7) same (synchron\$6 or timing or de\$1skew\$3 or skew\$3 or lat\$7 or retard\$6) same (pad\$4 or pin or terminal or port or channel) same (program or adjust or vari or vary or configur) same (maxim or optim)	0			
	L14	L13 and automat\$7 with test\$3 same calibrat\$3 same (ic or (integrat\$3 near2 circuit\$3) or semi\$1conduct\$7 or semi conduct\$7 or memor\$7) same (synchron\$6 or timing or de\$1skew\$3 or skew\$3 or lat\$7 or retard\$6) same (pad\$4 or pin or terminal or port or channel) same (program or adjust or vari or vary or configur)	16			
Ē	L13	L12 and automat\$7 with test\$3 same calibrat\$3 same (ic or (integrat\$3 near2 circuit\$3) or semi\$1conduct\$7 or semi conduct\$7 or memor\$7) same (synchron\$6 or timing or de\$1skew\$3 or skew\$3 or lat\$7 or retard\$6) same (pad\$4 or pin or terminal or port or channel)	48			
n	L12	L11 and automat\$7 with test\$3 same calibrat\$3 same (ic or (integrat\$3 near2 circuit\$3) or semi\$1conduct\$7 or semi conduct\$7 or memor\$7) same (synchron\$6 or timing or de\$1skew\$3 or skew\$3 or lat\$7 or retard\$6)	83			
	Lll	L10 and automat\$7 with test\$3 same calibrat\$3 same (ic or (integrat\$3 near2 circuit\$3) or semi\$1conduct\$7 or semi conduct\$7 or memor\$7)	423			
	L10	automat\$7 with test\$3 same calibrat\$3	2958			
n	L9	(shar\$3 or common or joint) near2 delay\$3 same automatic with test\$3 same (doubl\$4 or PARALLEL\$4 OR CONCUR\$7 OR PIPE\$1LIN\$4 OR SIMULTANE\$7 OR "SAME TIME" OR CONTEMPORan\$7 or CONTEMPO\$7 or contemporaneously) with (lead or pad\$4 or pin or terminal or port)	1			
	L8	shar\$3 near2 delay\$3 same automatic with test\$3 same (doubl\$4 or PARALLEL\$4 OR CONCUR\$7 OR PIPE\$1LIN\$4 OR SIMULTANE\$7 OR "SAME TIME" OR CONTEMPORan\$7 or CONTEMPO\$7 or contemporaneously) with (lead or pad\$4 or pin or terminal or port)	0			

g

e

L7	shar\$3 near2 delay\$3 same automatic with test\$3 same (doubl\$4 or PARALLEL\$4 OR CONCUR\$7 OR PIPE\$1LIN\$4 OR SIMULTANE\$7 OR "SAME TIME" OR CONTEMPORan\$7 or CONTEMPO\$7 or contemporaneously)	0
L6	11 and shar\$3 near2 delay\$3 same automatic with test\$3 same (doubl\$4 or PARALLEL\$4 OR CONCUR\$7 OR PIPE\$1LIN\$4 OR SIMULTANE\$7 OR "SAME TIME" OR CONTEMPORan\$7 or CONTEMPO\$7 or contemporaneously)	0
L5	11 and shar\$3 near2 delay\$3 same automatic test\$3 same (doubl\$4 or PARALLEL\$4 OR CONCUR\$7 OR PIPE\$1LIN\$4 OR SIMULTANE\$7 OR "SAME TIME" OR CONTEMPORan\$7 or CONTEMPO\$7 or contemporaneously)	0
L4	11 and shar\$3 near2 delay\$3 same automatic test\$3 and parallel\$3	0
L3	11 and shar\$3 near2 delay\$3 same automatic test\$3 same parallel\$3	0
L2	11 and shar\$3 near2 delay\$3 bsame automatic test\$3	0
L1	shar\$3 near2 delay\$3	1022

END OF SEARCH HISTORY